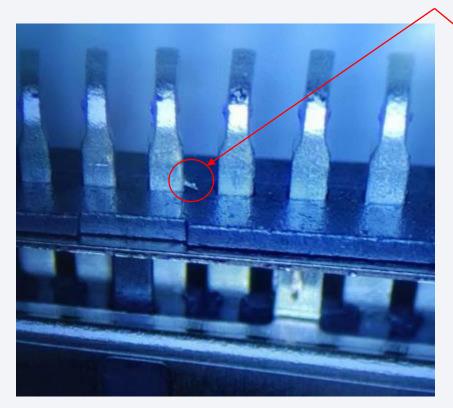
	Amphenol Canada	Corp - Product Cha	nge Noti	ce (PCN	۷)			
PCN Date		March 22, 2024						
Supplier Name:		Amphenol HSIO						
Amphenol Canada PCN Numb	er	PCN-C1804						
Description of Change		The plating process at the Tin pla	ating area is cha	anged from th	ne dip plating to	the spot plating.		
Reason for Change		To improve the plating process quality, efficiency, and productivity to support the increasing demand.						
Summary of changes between	new and old part	See next page for detail change. Amphenol part numbers not changed.						
Traceability guidelines (lot coodate)	le / date code, markings, ship	Date code						
Last Time Buy Date								
Datasheet attached? & Filena	me(s)	N/A						
Qual Test data attached? & Fi	lename(s)	N/A						
Customer Part Number	Amphenol Old Part Number	Amphenol New Part Number	PCN Effectivity Date	Samples Availability Date	Last Time Buy Date	Expected Supplier Qual Date		
664-UE62A10123000TTR-N	UE62-A1012-3000T	No change	21-May-24	22-Mar-24				
664-UE62A10123100TTR-N	UE62-A1012-3100T	No change	21-May-24	22-Mar-24				

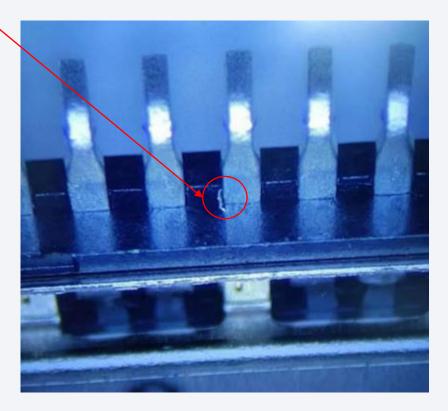


1 Reason for Change



Tin flash

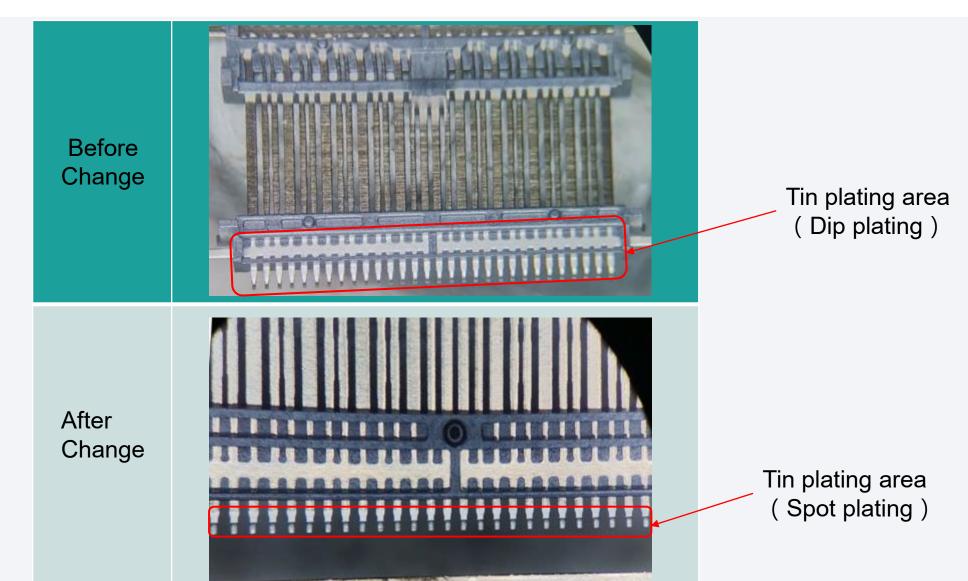




Current Tin plating area is large which is easy to cause Tin flash during molding process. It also caused too much time to clear it manually. To increase the capacity and improve the quality control, the plating process at Tin area needs to be changed from dip plating to spot plating.

2 Appearance comparison for wafer

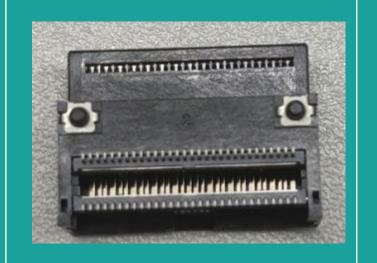


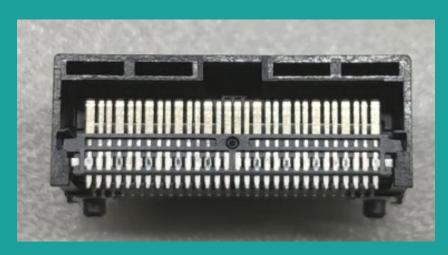


3 · Appearance comparison for connector

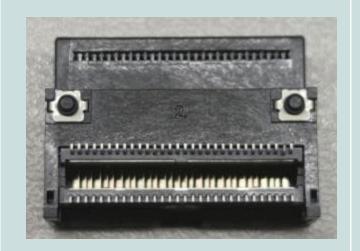


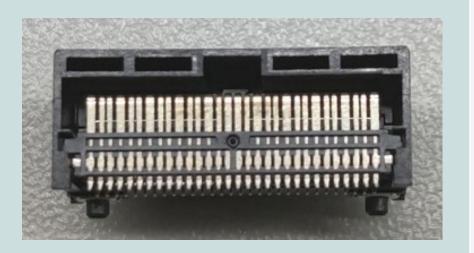
Before Change





After Change

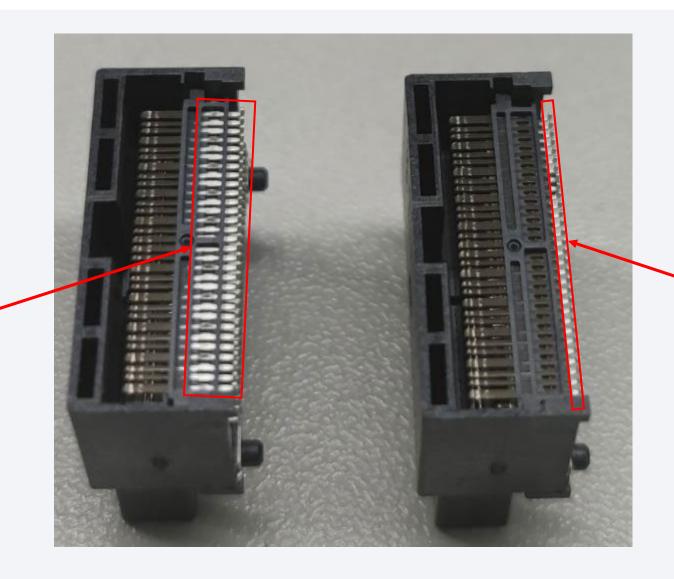




4 Appearance comparison for connector



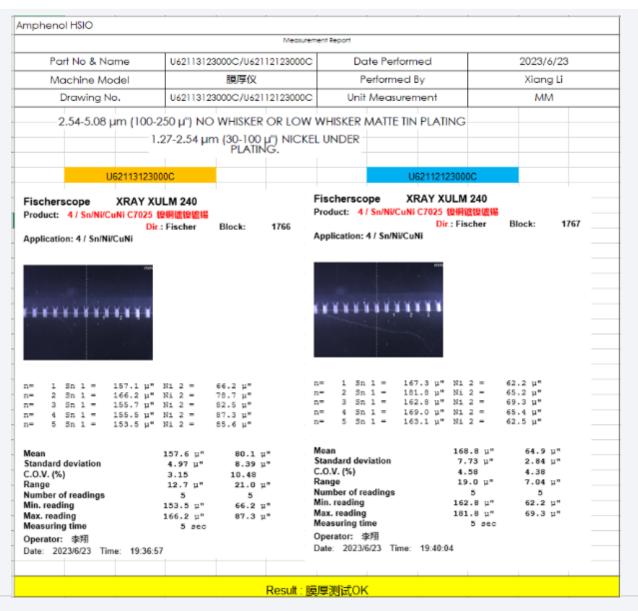
Tin plating area Before change



Tin plating area After change

5 Plating Inspection for Tin spot plating



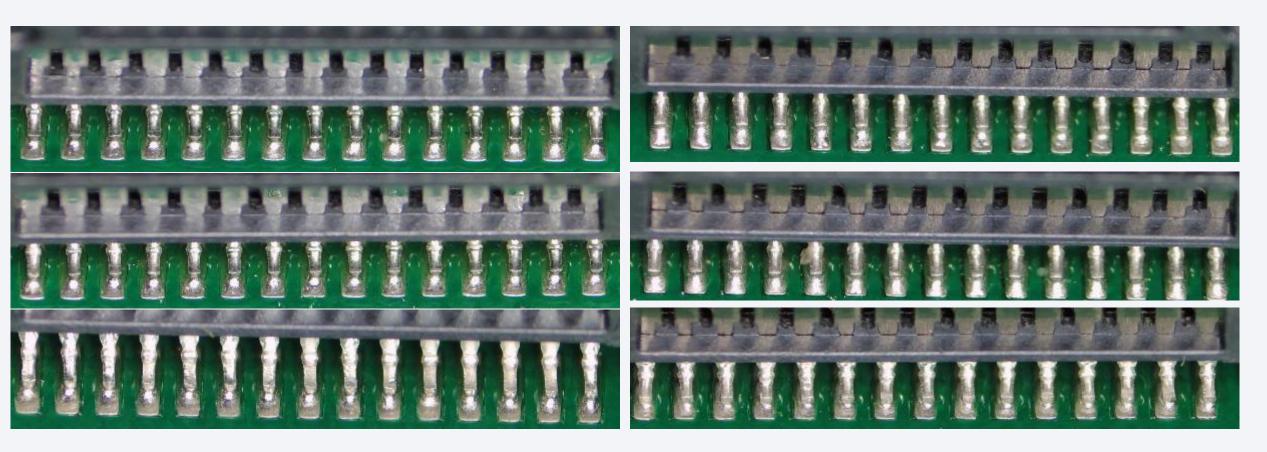


6 Solderability test



Before change

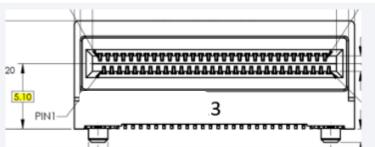
After change



This change will not affect the solderability.

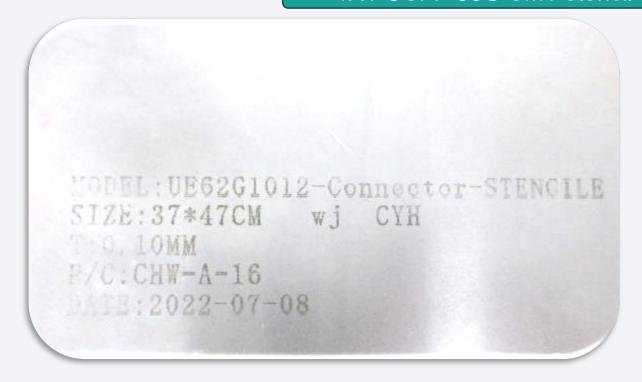
7. OSFP 56G 1X1 Re-flow test for belly to belly application





	Before reflow								After reflow (twice)							
litem	SPEC	Remar k	1	2	3	4	5	Result	Item	SPEC	Remar k	1	2	3	4	5
1	5.10+/-0.13	Left	5.115	5.108	5.117	5.119	5.104	OK	1 5.10+/-0.13	Left	5.094	5.141	5.122	5.100	5.097	
1		Right	5.085	5.079	5.078	5.084	5.068			Right	5.075	5.099	5.072	5.073	5.073	
Solder	paste thickness	/	0.128	0.128	0.130	0.126	0.122	/	/ Solder paste thickness		/	0.143	0.142	0.145	0.143	0.145

1X1 OSFP 56G SMT stencil thickness is 0.10mm



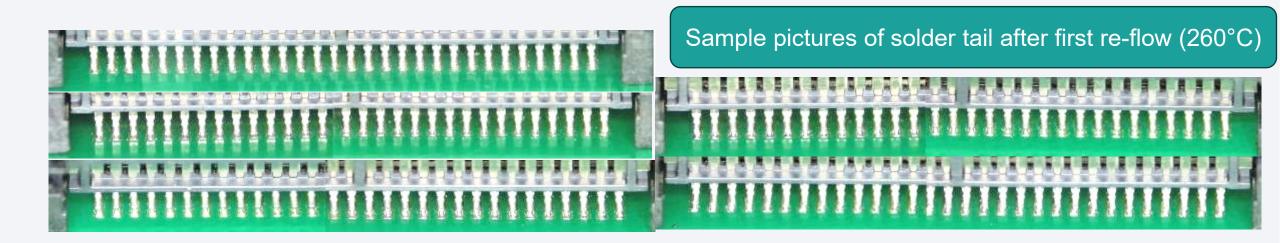


7. OSFP 56G 1X1 Re-flow test for belly to belly application



Sample pictures for the first re-flow (260°C)





7. OSFP 56G 1X1 Re-flow test for belly to belly application

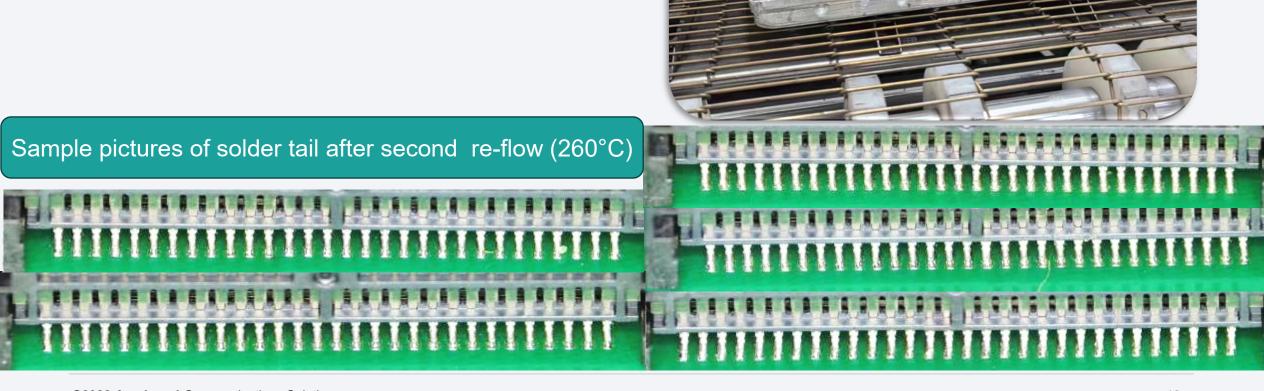


Sample pictures for after the

second re-flow crossing (260°C)

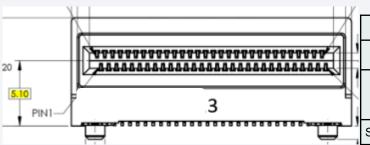
Connector side down did not fall off after second re-flow test.

Result: OK



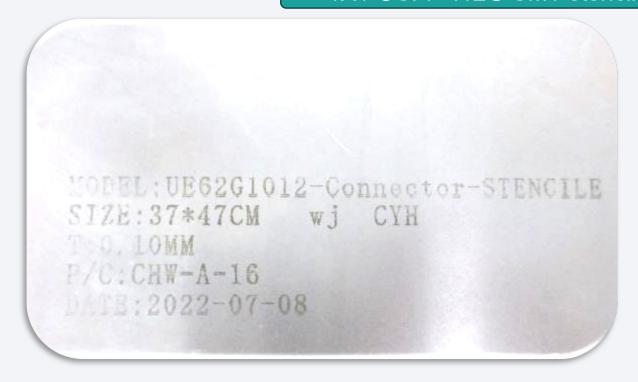
8. OSFP 112G 1X1 Re-flow test for belly to belly application





١	Before reflow								After reflow (twice)								
#	litem	SPEC	Remark	1	2	3	4	5	Result	Item	SPEC	Remar k	1	2	3	4	5
1	1	5.10+/-0.10	Left	5.064	5.099	5.067	.067 5.061 5.089 OK	5.40.70.42	Left	5.071	5.093	5.070	5.077	5.075			
٦ì		5.10+/-0.10	Right	5.086	5.124	5.095	5.093	5.114		ı	5.10+/-0.13	Right	5.112	5.113	5.109	5.083	5.124
	Solder	paste thickness	1	0.135	0.118	0.103	0.107	0.126	/	So	der paste thickness	/	0.136	0.133	0.143	0.145	0.143

1X1 OSFP 112G SMT stencil thickness is 0.10mm

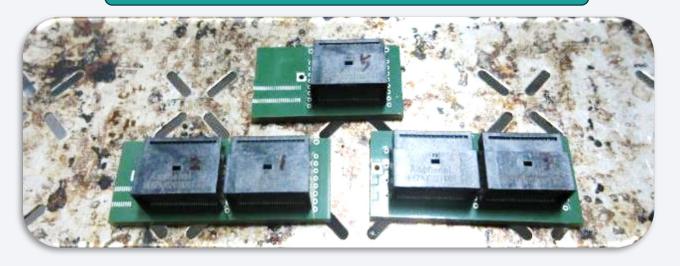




8. OSFP 112G 1X1 Re-flow test for belly to belly application



Sample pictures for the first re-flow (260°C)





8. OSFP 112G 1X1 Re-flow test for belly to belly application

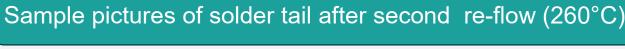


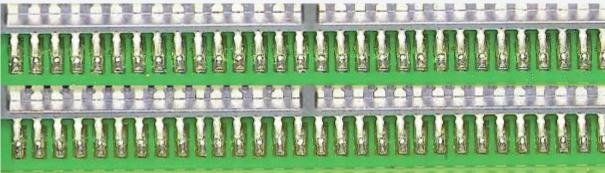
Connector side down did not fall off after second re-flow test.

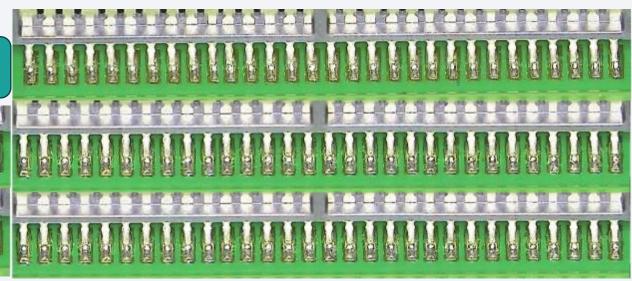
Result: OK

Sample pictures for after the second re-flow crossing (260°C)











Test Setup



- S-Parameter Results
- Frequency: 10MHz TO 54GHz, 10MHz steps

MCB **HCTF HCB**

Crosstalk Configuration



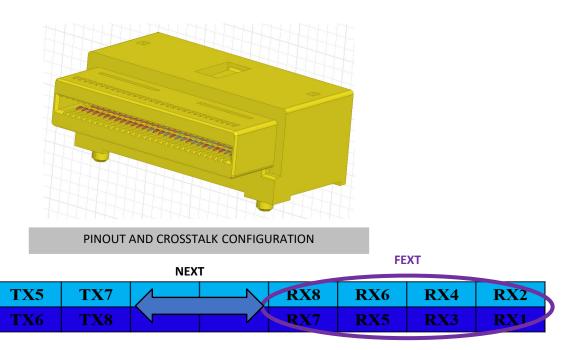
OSFP SMT1x1 Connector

TX1

TX2

TX3

TX4



Report Setup



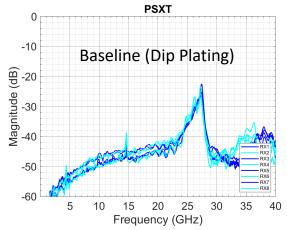
- \\ahsio-silab\Measurement_Data\connector\OSFP\202311\OSFP
 1X1\MCB_L203r7_42_HCB_L354r2_29_dip plating
 sample\report\OSFP_1X1_MCB_L203r7_42_HCB_L354r2_29_dip plating sample_convert.s64p
- \\ahsio-silab\Measurement_Data\connector\OSFP\202311\OSFP
 1X1\MCB_L203r7_43_HCB_L354r2_29_spot plating
 sample\report\OSFP_1X1_MCB_L203r7_43_HCB_L354r2_29_spot plating sample_convert.s64p

Conclusion

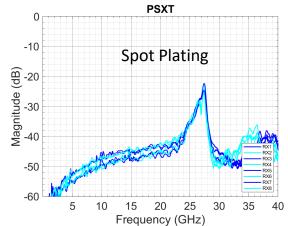


• Spot plating process have very little effect on SI performance of OSFP56 1x1 connector, comparing to the baseline connector with dip plating process.

ICN



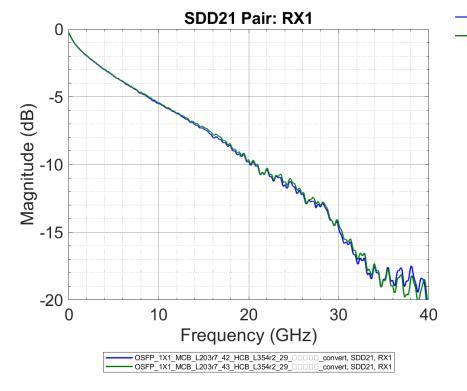
Pair	ICN NEXT	ICN FEXT	ICN Total
SPEC	1.5	4.2	4.4
RX1	0.118	1.75	1.754
RX2	0.129	1.739	1.744
RX3	0.075	2.277	2.278
RX4	0.101	2.278	2.28
RX5	0.118	2.3	2.303
RX6	0.137	2.279	2.284
RX7	0.2	1.727	1.738
RX8	0.218	1.672	1.687



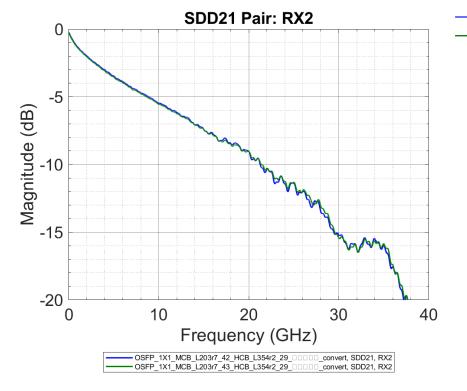


Pair	ICN NEXT	ICN FEXT	ICN Total
SPEC	1.5	4.2	4.4
RX1	0.168	1.709	1.718
RX2	0.255	1.751	1.77
RX3	0.116	2.241	2.244
RX4	0.11	2.174	2.177
RX5	0.132	2.266	2.27
RX6	0.135	2.23	2.234
RX7	0.234	1.647	1.664
RX8	0.229	1.63	1.646

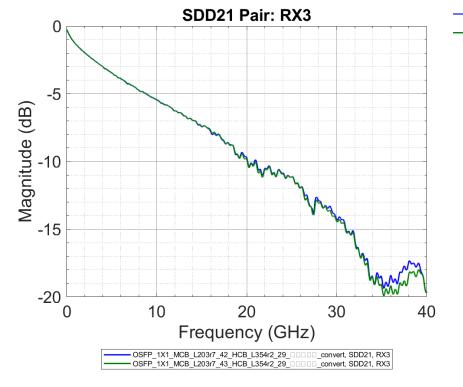




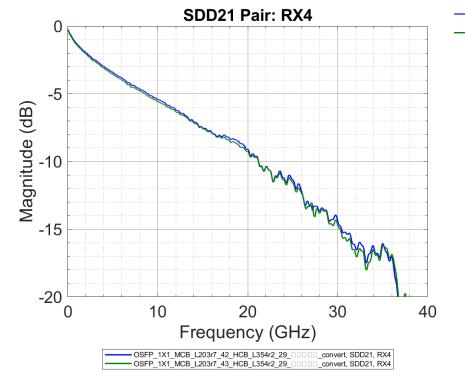




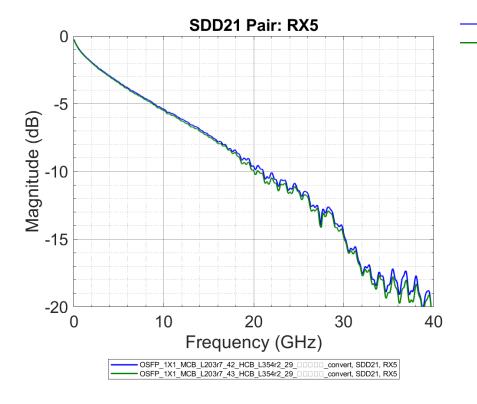




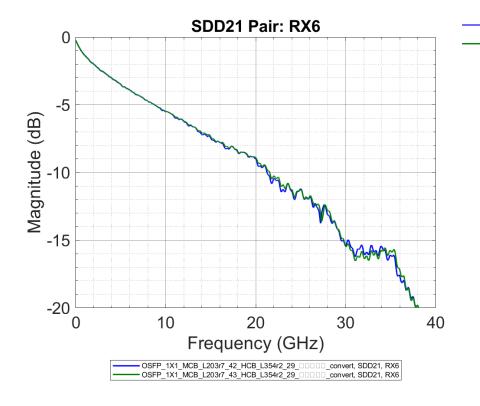




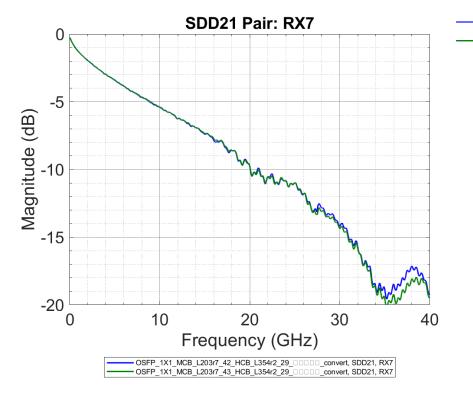




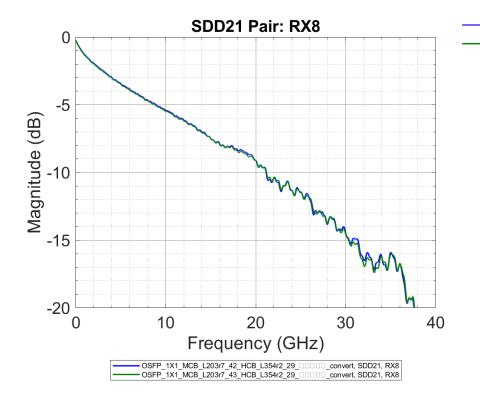








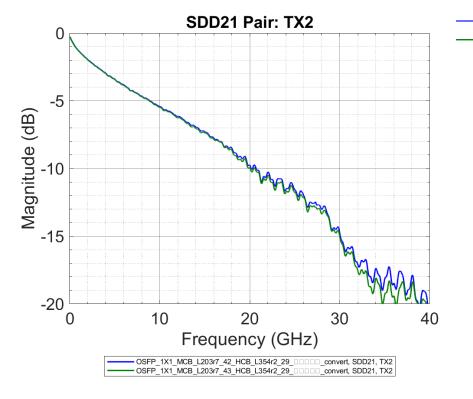




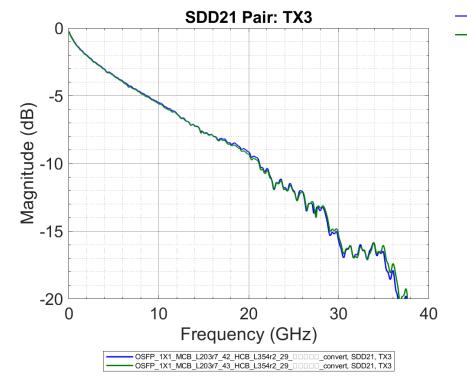












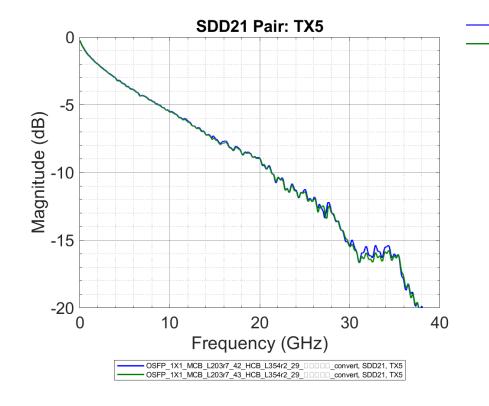






Baseline Dip Plating

Spot Plating



High Speed IO



